

BLF7G20LS-140P

Power LDMOS transistor

Rev. 2 — 17 August 2010

Product data sheet

1. Product profile

1.1 General description

140 W LDMOS power transistor for base station applications at frequencies from 1800 MHz to 2000 MHz.

Table 1. Typical performance

Typical RF performance at $T_{case} = 25^\circ\text{C}$ in a common source class-AB production test circuit.

Mode of operation	f (MHz)	I_{Dq} (mA)	V_{DS} (V)	$P_{L(AV)}$ (W)	G_p (dB)	η_D (%)	$\text{ACPR}_{400\text{k}}$ (dBc)	$\text{ACPR}_{600\text{k}}$ (dBc)	EVM_{rms} (%)
CW	1805 to 1880	850	28	125	17	54	-	-	-
GSM EDGE	1805 to 1880	850	28	60	17.5	41	-61	-75	2.7

1.2 Features and benefits

- Excellent ruggedness
- High efficiency
- Low R_{th} providing excellent thermal stability
- Designed for broadband operation (1800 MHz to 2000 MHz)
- Lower output capacitance for improved performance in Doherty applications
- Designed for low memory effects providing excellent pre-distortability
- Internally matched for ease of use
- Integrated ESD protection
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

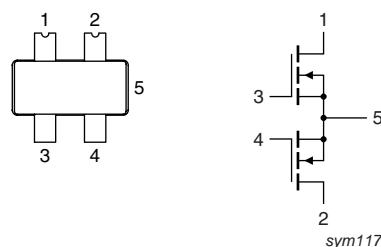
1.3 Applications

- RF power amplifiers for base stations and multi carrier applications in the 1800 MHz to 2000 MHz frequency range



2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	drain1		
2	drain2		
3	gate1		
4	gate2		
5	source	[1]	

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

Type number	Package			Version
	Name	Description		
BLF7G20LS-140P	-	earless flanged LDMOST ceramic package; 4 leads		SOT1121B

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	65	V
V_{GS}	gate-source voltage		-0.5	+13	V
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature		-	200	°C

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	$T_{case} = 80$ °C; $P_L = 100$ W	0.41	K/W

6. Characteristics

Table 6. Characteristics

$T_j = 25^\circ\text{C}$; per section unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(\text{BR})\text{DSS}}$	drain-source breakdown voltage	$V_{\text{GS}} = 0\text{ V}$; $I_D = 0.9\text{ mA}$	65	-	-	V
$V_{\text{GS}(\text{th})}$	gate-source threshold voltage	$V_{\text{DS}} = 10\text{ V}$; $I_D = 90\text{ mA}$	1.5	1.9	2.3	V
I_{DSS}	drain leakage current	$V_{\text{GS}} = 0\text{ V}$; $V_{\text{DS}} = 28\text{ V}$	-	-	2	μA
I_{DSX}	drain cut-off current	$V_{\text{GS}} = V_{\text{GS}(\text{th})} + 3.75\text{ V}$; $V_{\text{DS}} = 10\text{ V}$	14	-	-	A
I_{GSS}	gate leakage current	$V_{\text{GS}} = 11\text{ V}$; $V_{\text{DS}} = 0\text{ V}$	-	-	200	nA
g_{fs}	forward transconductance	$V_{\text{DS}} = 10\text{ V}$; $I_D = 2.5\text{ A}$	-	6.45	-	S
$R_{\text{DS}(\text{on})}$	drain-source on-state resistance	$V_{\text{GS}} = V_{\text{GS}(\text{th})} + 3.75\text{ V}$; $I_D = 3.15\text{ A}$	-	0.15	-	Ω

7. Test information

Table 7. Application information

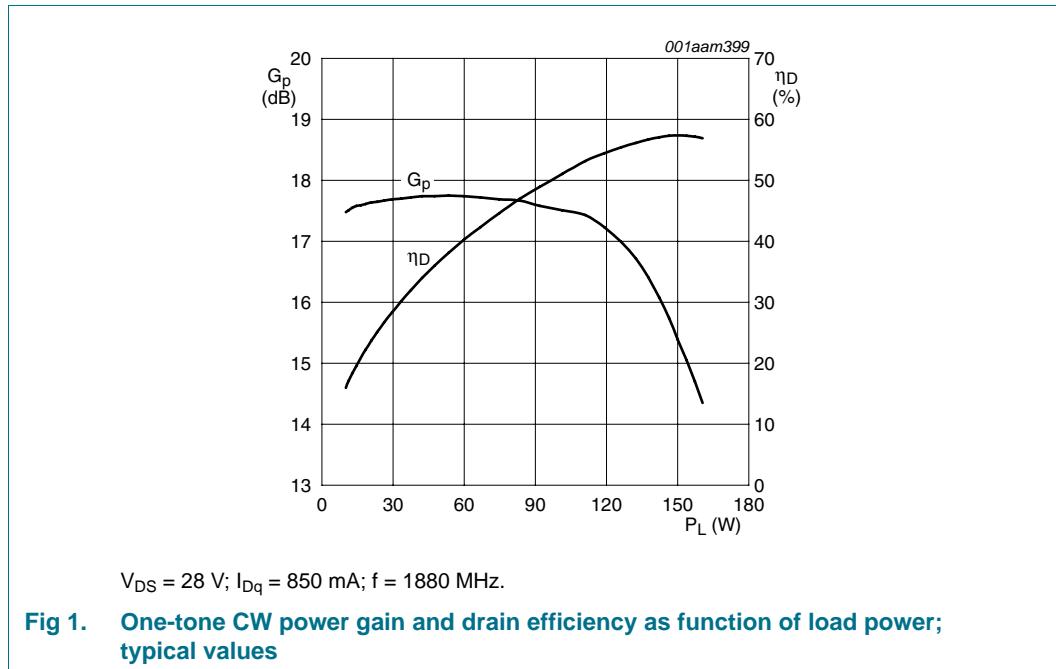
$f = 1805\text{ MHz}$ and 1880 MHz ; RF performance at $V_{\text{DS}} = 28\text{ V}$; $I_{\text{Dq}} = 850\text{ mA}$; $T_{\text{case}} = 25^\circ\text{C}$;
2 sections combined unless otherwise specified; in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Mode of operation: GSM EDGE; $P_{\text{L}(\text{AV})} = 60\text{ W}$						
G_p	power gain		16.3	17.5	-	dB
RL_{in}	input return loss		-	-15	-8	dB
η_D	drain efficiency		37	41	-	%
$\text{ACPR}_{400\text{k}}$	adjacent channel power ratio (400 kHz)		-	-61	-56.5	dBc
$\text{ACPR}_{600\text{k}}$	adjacent channel power ratio (600 kHz)		-	-75	-69.5	dBc
EVM_{rms}	RMS EDGE signal distortion error		-	2.7	4.0	%
EVM_M	peak EDGE signal distortion error		-	8.5	12.5	%
Mode of operation: CW; $P_{\text{L}(\text{AV})} = 125\text{ W}$						
G_p	power gain		16	17	-	dB
η_D	drain efficiency		48	54	-	%

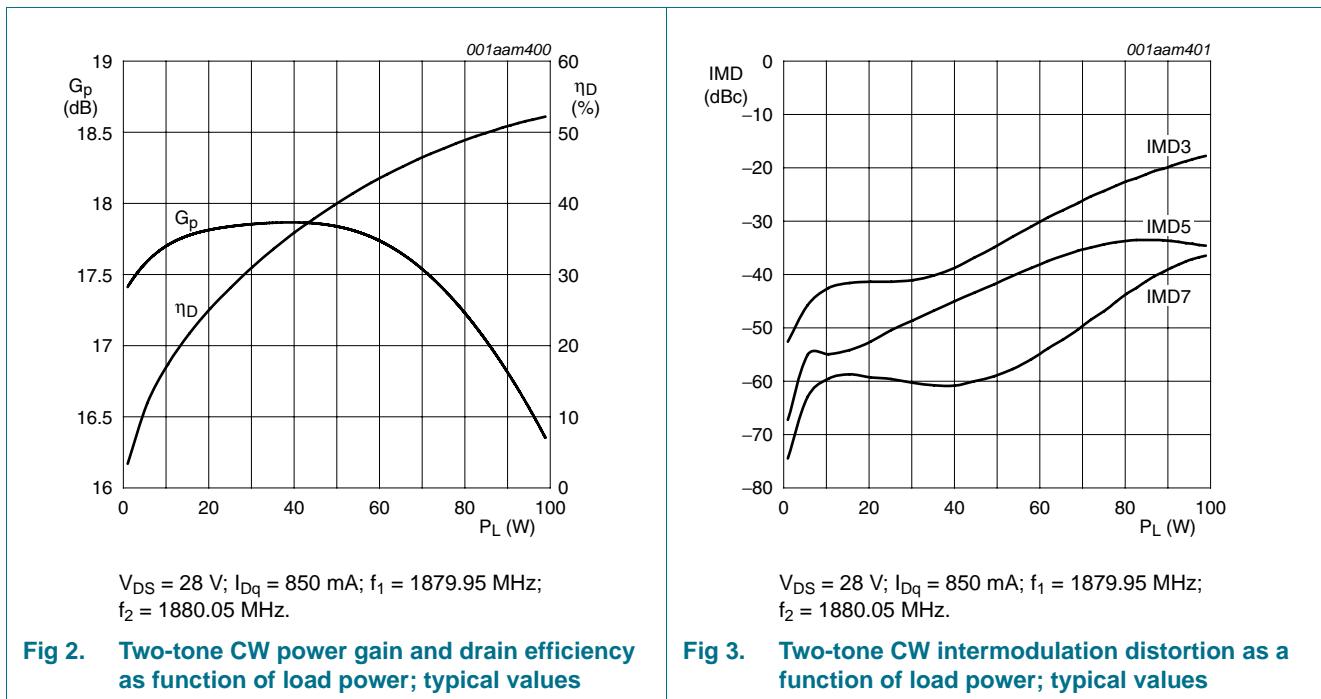
7.1 Ruggedness in class-AB operation

The BLF7G20LS-140P is capable of withstanding a load mismatch corresponding to $\text{VSWR} = 10 : 1$ through all phases under the following conditions: $V_{\text{DS}} = 28\text{ V}$;
 $I_{\text{Dq}} = 850\text{ mA}$; $P_{\text{L}} = 140\text{ W}$ (CW); $f = 1805\text{ MHz}$.

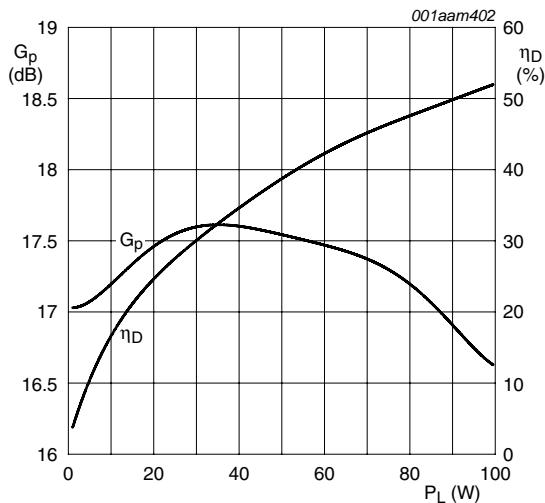
7.2 One-tone CW



7.3 Two-tone CW

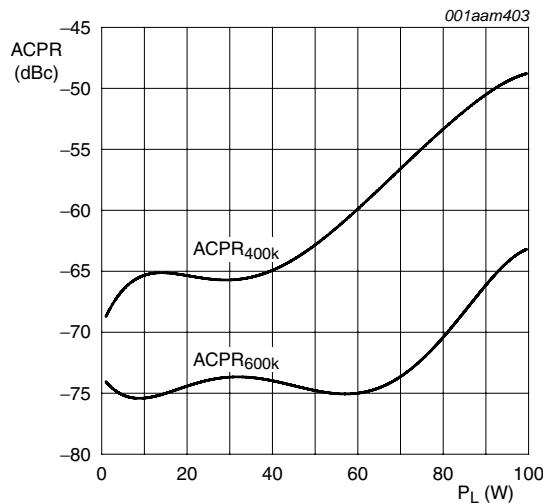


7.4 GSM EDGE



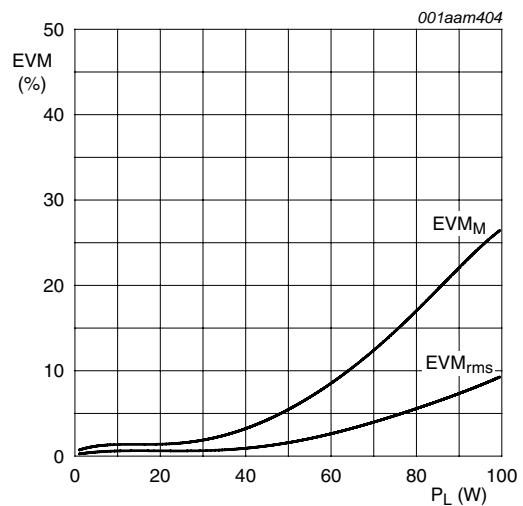
$V_{DS} = 28$ V; $I_{Dq} = 850$ mA; $f = 1880$ MHz.

Fig 4. GSM EDGE power gain and drain efficiency as function of load power; typical values



$V_{DS} = 28$ V; $I_{Dq} = 850$ mA; $f = 1880$ MHz.

Fig 5. GSM EDGE ACPR at 400 kHz and at 600 kHz as function of load power; typical values

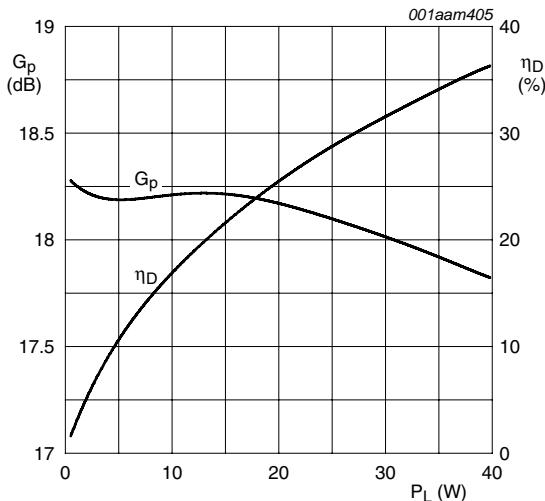


$V_{DS} = 28$ V; $I_{Dq} = 850$ mA; $f = 1880$ MHz.

Fig 6. GSM-EDGE RMS EVM and peak EVM as function of load power; typical values

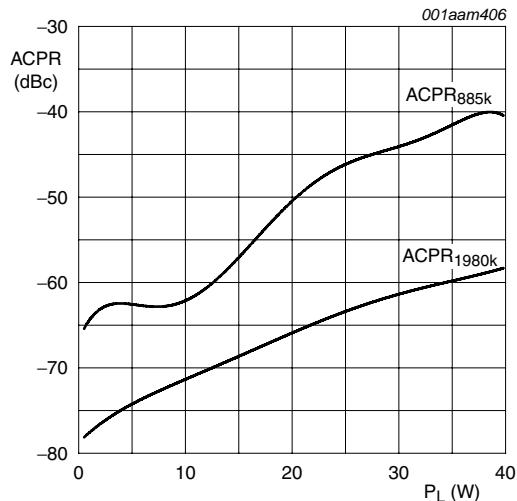
7.5 Single carrier IS-95

Single carrier IS-95 with pilot, paging, sync and 6 traffic channels (Walsh codes 8 - 13). PAR = 9.7 dB at 0.01 % probability on the CCDF. Channel bandwidth is 1.2288 MHz.



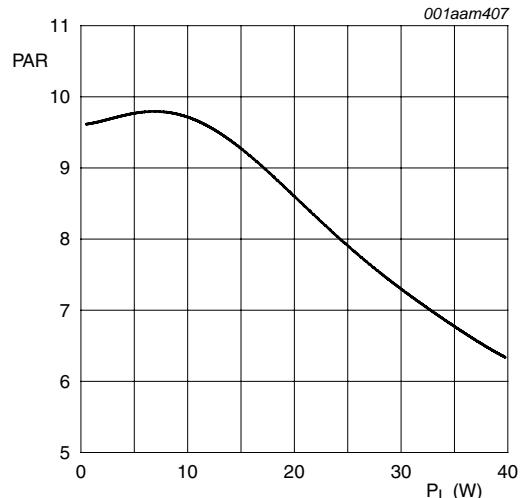
$V_{DS} = 28$ V; $I_{Dq} = 1080$ mA; $f = 1880$ MHz.

Fig 7. Single carrier IS-95 power gain and drain efficiency as function of load power; typical values



$V_{DS} = 28$ V; $I_{Dq} = 1080$ mA; $f = 1880$ MHz.

Fig 8. Single carrier IS-95 ACPR at 885 kHz and at 1980 kHz as function of load power; typical values

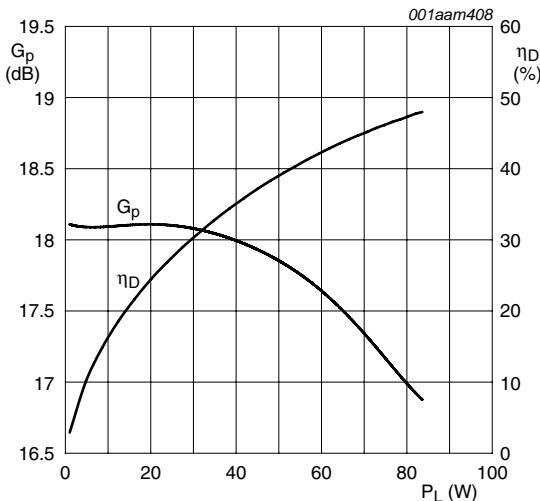


$V_{DS} = 28$ V; $I_{Dq} = 1080$ mA; $f = 1880$ MHz.

Fig 9. Single carrier IS-95 peak-to-average power ratio as a function of load power; typical values

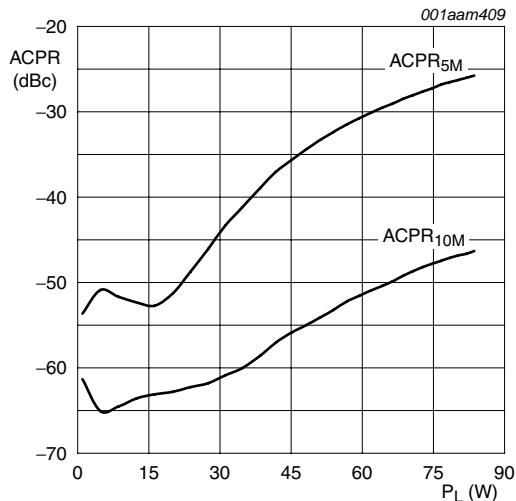
7.6 Single carrier W-CDMA

3GPP; test model 1; 64 DPCH; PAR = 7.2 dB at 0.01 % probability on CCDF.
Channel bandwidth is 3.84 MHz.



$V_{DS} = 28$ V; $I_{Dq} = 1080$ mA; $f = 1880$ MHz.

Fig 10. Single carrier W-CDMA power gain and drain efficiency as function of load power; typical values



$V_{DS} = 28$ V; $I_{Dq} = 1080$ mA; $f = 1880$ MHz.

Fig 11. Single carrier W-CDMA ACPR at 5 MHz and at 10 MHz as function of load power; typical values

7.7 Test circuit

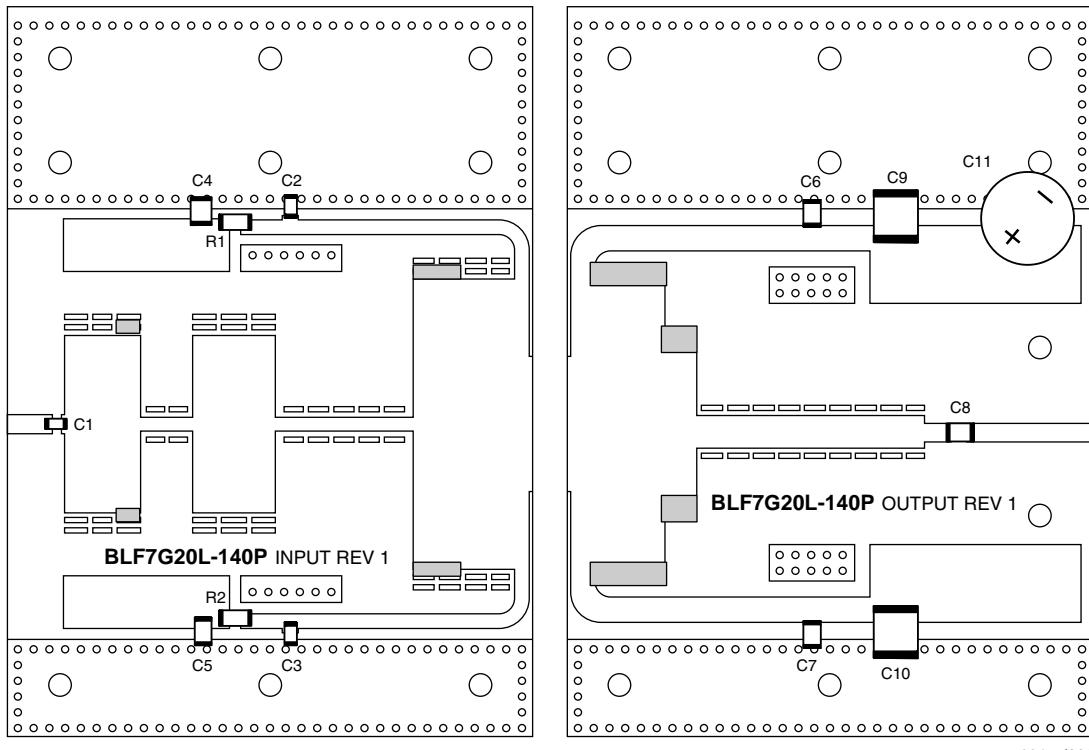
Table 8. List of components
For test circuit see [Figure 12](#).

Component	Description	Value	Remarks
C1, C2, C3	multilayer ceramic chip capacitor	24 pF	[1]
C4, C5	multilayer ceramic chip capacitor	4.7 μ F	[2]
C6, C7, C8	multilayer ceramic chip capacitor	11 pF	[3]
C9, C10	multilayer ceramic chip capacitor	10 μ F	[2]
C11	electrolytic capacitor	470 μ F; 63 V	
R1, R2	SMD resistor	12 Ω	Philips 1206

[1] American Technical Ceramics type 100A or capacitor of same quality.

[2] TDK or capacitor of same quality.

[3] American Technical Ceramics type 100B or capacitor of same quality.



Printed-Circuit Board (PCB): Taconic RF35; $\epsilon_r = 3.5$ F/m; thickness = 0.76 mm; thickness copper plating = 35 μm .

See [Table 8](#) for a list of components.

Fig 12. Component layout for class-AB production test circuit

7.8 Impedance information

Table 9. Typical impedance

Typical values valid for both section in parallel unless otherwise specified.

f MHz	Z_s Ω	Z_L Ω
1800	1.1 – j3.8	1.8 – j2.8
1840	1.3 – j3.7	1.7 – j2.6
1880	1.2 – j3.8	1.6 – j2.5

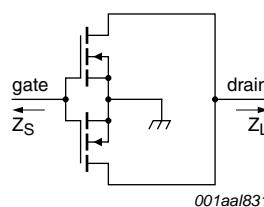
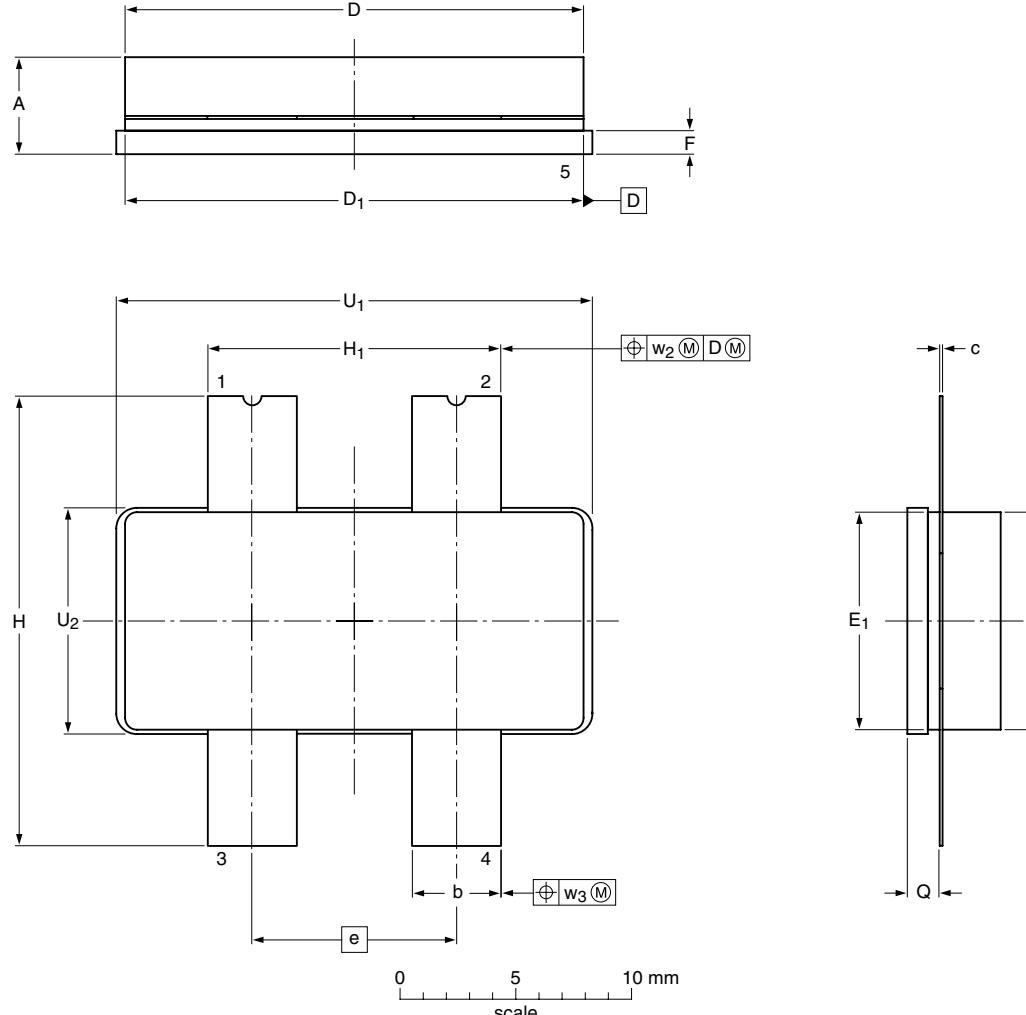


Fig 13. Definition of transistor impedance

8. Package outline

Earless flanged LDMOST ceramic package; 4 leads

SOT1121B



Dimensions

Unit ⁽¹⁾	A	b	c	D	D ₁	e	E	E ₁	F	H	H ₁	Q	U ₁	U ₂	w ₂	w ₃
mm	max 4.75	3.94	0.18	20.02	19.96		9.53	9.53	1.14	19.94	12.83	1.70	20.70	9.91		
mm	nom					8.89									0.51	0.25
mm	min 3.45	3.68	0.08	19.61	19.66		9.27	9.27	0.89	18.92	12.57	1.45	20.45	9.65		
inches	max 0.187	0.155	0.007	0.788	0.786		0.375	0.375	0.045	0.785	0.505	0.067	0.815	0.39		
inches	nom					0.35									0.02	0.01
inches	min 0.136	0.145	0.003	0.772	0.774		0.365	0.365	0.035	0.745	0.495	0.057	0.805	0.38		

Note

1. millimeter dimensions are derived from the original inch dimensions.

2. dimension is measured 0.030 inch (0.76 mm) from the body.

sot1121b_p0

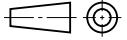
Outline version	References			European projection	Issue date
	IEC	JEDEC	JEITA		
SOT1121B					09-10-12-09-12-14

Fig 14. Package outline SOT1121B

9. Abbreviations

Table 10. Abbreviations

Acronym	Description
CW	Continuous Wave
EDGE	Enhanced Data rates for GSM Evolution
ESD	ElectroStatic Discharge
GSM	Global System for Mobile communications
IS-95	Interim Standard 95
LDMOS	Laterally Diffused Metal Oxide Semiconductor
LDMOST	Laterally Diffused Metal Oxide Semiconductor Transistor
RF	Radio Frequency
SMD	Surface Mounted Device
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

10. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF7G20LS-140P v.2	20100817	Product data sheet	-	BLF7G20L-140P_7G20LS-140P v.1
Modifications:	<ul style="list-style-type: none"> This document now only describes the BLF7G20LS-140P. Table 1 on page 1: changed some values. Table 4 on page 2: removed drain current specification. Table 6 on page 3: added typical value for g_{fs}. Table 7 on page 3: changed some values. Section 7.2 on page 4: updated the figures. Section 7.3 on page 4: updated the figures. Section 7.4 on page 5: updated the figures. Section 7.5 on page 6: updated the figures. 			
BLF7G20L-140P_7G20LS-140P v.1	20100421	Objective data sheet	-	-

11. Legal information

11.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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